# **EPS150TESLA**

150 mm Manual Probing Solution for High-Power Applications

#### Overview

The EPS150TESLA is a very cost-effective and simple, yet highly precise probing solution for high-voltage, high-current and high-power measurements of power devices on substrates and wafers up to 150 mm.

The ergonomically-designed EPS150TESLA allows precise, yet intuitive single-handed operation. A pull-out stage allows quick and safe loading and unloading of the DUT.

The unique SIGMA™ options allow seamless integration, ensuring accurate measurement results, ease-of-use, and fast system configuration and set-up for various devices. The SIGMA option for Keysight B1505A with "Keysight-verified" cabling and connections eliminates risks of misconfiguration and inaccurate measurement results.

High-temperature chucks up to 300°C and up to 3,000 V isolation in combination with low-leakage performance provide an excellent measurement environment for vertical devices. High-voltage (up to 3,000 V) and high-current probe arms (up to 40 A pulsed) use standard tips and/or replaceable HCP probe tips to lower your measurement costs. The chuck design with SIGMA options enables precise measurement of leakage current down to a few picoAmps.



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### > Features / Benefits

Operator safety and device protection	<ul> <li>Safety category 1 interlocks on a dark box door</li> <li>Dedicated chuck design for highest isolation</li> <li>Unique high-voltage probe arm design with protected guard area</li> </ul>
Measurement accuracy	<ul> <li>Low-noise test environment with EMI-shield concept extended for high-voltage, high-current and high-power applications</li> <li>SIGMA options for seamless integration of measurement equipment for best measurement accuracy</li> </ul>
Low cost-of-ownership	<ul> <li>Probe concept allows expansion for other applications such as RF (S-parameter) measurements</li> <li>Unique high-voltage and high-current probe arms designed for standard probe tips and/or replaceable HCP probe tips</li> </ul>



### > Power Handling (Chuck\*)

Maximum voltage	3,000 V (triax and coax) (Thermal Chuck: capable of 3 kV @ 200°C and 2.5 kV @ 300°C)

Maximum current 40 A (pulsed), 2 A (DC)

### > Measurement Performance

#### **EPS150TESLA Chuck (Triaxial Configuration)**

	Thermal Chuck	Thermal Chuck	Non-Thermal Chuck	
Chuck leakage	@ Ambient	@ 300°C	@ Ambient	
10V (typical)	100 fA	200 fA	50 fA	
3kV (typical)	10 pA	50 pA**	1pA	
Chuck resistance	Ambient		Ambient	
Force-Guard (10 V)	25 ΤΩ		25 ΤΩ	
Force-Shield (10 V)	3 ΤΩ		3 ΤΩ	
Guard-Shield (10 V)	500 GΩ		500 GΩ	
Probe leakage	Ambient		Ambient	
10 V (typical)	< 10 fA		< 10 fA	
3 kV (typical)	<1 pA		<1pA	

<sup>\*</sup> Performance valid when using the chuck dry air purging with -65°C dew-point air.

# > Chuck System

Diameter	150 mm
DUT sizes supported	10 mm x 10 mm, 2 inch, 4 inch and 6 inch wafers
Sureface	Gold-plated
Supported wafer thickness	≥100 µm
Configuration	Triaxial design

# > Non-Thermal Chuck System

Flatness ≤10 μm

# > Thermal Chuck System

Temperature range	+30°C to 300°C
Resolution	0.1°C
Accuracy	± 1°C and ± 1% above 100°C
Flatness	$\leq$ 10 $\mu$ m at ambient, $\leq$ 30 $\mu$ m at 200°C
Transition rate (from 30°C to 300°C): ATT	25 min.*
Transition rate (from 30°C to 300°C): ERS	36 min.

<sup>\*</sup> Measured with internal Chuck RTD.

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<sup>\*</sup> In combination with EPS-ACC-150T-AG SIGMA. Up to 10 kV coax and 100 A performance available on special request.

<sup>\*\*</sup> At 2.5 kV

# > Mechanical Performance

### Chuck Stage

Travel	155 mm x 155 mm (6 inch x 6 inch)
Resolution	5 μm
Planarity over 150 mm (6 inch)	<10 μm
Load stroke, Y axis	90 mm
Z height adjustment range	10 mm
Z contact / separation / load stroke	0-3 mm adjustable
Theta travel (fine)	±8°
Theta resolution	7.5 x 10-3 gradient
Platen	
Platen space (typical)	Universal platen: space for up to eight RPP210
Z-Height adjustment range	Maximum 20 mm (depending on configuration)
Minimum platen-to-chuck height	16 mm (universal platen)
Separation lift	200 μm
Separation repeatability	<1 µm
Vertical rigidity / force	5 μm / 10 N (0.2 mils / 2.2 lb.)
Accessory mounting	Magnetic
Manual Microscope Stage (On Bridge)	
Travel range	50 mm x 50 mm (2 inch x 2 inch)
Resolution	≤ 5 µm (0.2 mils)
Microscopes	For stereo microscopes with large working distance

# **>** Microscope

Туре	Trinocular stereo zoom
Zoom range	1: 6.7
Magnification	15-100x
Camera port	For cameras with C-mount
Illumination	Long life-time LED ring light

# **>** Safety

Interlock	Hardware (safety category 1)
Interlock connector	BNC-Twinax (specific interlock cables available for various measurement instruments, e.g. Keysight B1505A

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 $<sup>*</sup> See\ Probe\ Station\ Accessory\ Catalog\ for\ power\ requirements\ for\ accessories\ and\ ERS\ Air Cool 3\ Facility\ Planning\ Guide\ for\ power\ requirements\ for\ thermal\ chuck.$ 

## > Ordering Information

Part Number	Description
EPS150TESLA	150 mm manual probing solution* for high-power applications (chuck option required)
OPT-EPS-150T-NT	Non-thermal chuck for EPS150TESLA
OPT-EPS-150T-300C	Thermal chuck for EPS150TESLA (ambient to 300°C, capable of 3 kV/200°C and 2.5 kV/300°C), ERS
OPT-EPS-150T-300CA	Thermal chuck for EPS150TESLA (ambient to 300°C, capable of 3 kV/200°C and 2.5 kV/300°C), ATT
EPS-ACC-150T-AG**	SIGMA for Keysight B1505A, complete application integration including positioners, probes, tips, cables, adapters and interface
EPS-ACC-150T-AG-LT**	SIGMA for Keysight B1505A light, application integration including cables, adapters and interface
EPS-ACC-150T-AG-MS	Mount for Keysight B1505A module selector
EPS-ACC-150T-PCA	Probe card holder option for EPS150TESLA for non-arcing 4.5-inch probe cards
EPS-ACC-HDTV	Digital high-definition TV option for EPS packages containing C-mount HDTV camera, cables, power supply and 22" monitor, with crosshair overlay

<sup>\*</sup> The EPS150TESLA manual probing solution includes: MPS150 probe station with a 150 mm chuck stage, a platen (20 mm height adjustment), fine chuck rotation, manual scope transport on bridge, camera-ready stereo zoom microscope with 15x - 100x magnification and LED illumination, vibration-isolation solution, EMIshielded safety enclosure, mounted on a table, tweezers, and all tools for setup and operation. Requires thermal or non-thermal chuck option.

## > Regulary Compliance

Certification CE

# **>** Warranty

Warranty*	Fifteen months from date of delivery or twelve months from date of installation
Service Contracts	Single and multi-year programs available to suit your needs

<sup>\*</sup>See FormFactor's Terms and Condition of Sales for more details.

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<sup>\*\*</sup>SIGMA kit designed for B1505A supporting MCSMU, MPSMU, HCSMU, HPSMU and HVSMU in combination with Protection Adapters #N1261A-001/-002/-003/-004, #16493S-010/-011 and Bias T #N1260A.